

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

FUJISAWA ET AL.

Examiner

JASON RECEK

Art Unit

2442

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

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